

## FGY60T120SWD-VB Datasheet

### 1200V Trench and Fieldstop IGBT

PRODUCT SUMMARY		
V <sub>CE</sub> (V)	1200	
I <sub>C</sub> (A)	150 (TC=25 °C)	75 (TC=100 °C)
V <sub>CE (sat)</sub> (V)	1.8	
I <sub>CM</sub> (A)	225	

#### FEATURES

- Very Low V<sub>CEsat</sub>
- Low turn-off losses
- High speed switching
- Maximum junction temperature 175°C
- Ultra low gate charge (Q<sub>g</sub>)
- Avalanche energy rated (UIS)



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

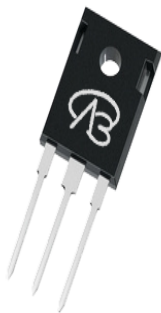
#### APPLICATIONS

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing
  - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)

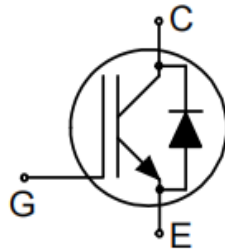
#### Package pin definition

- Pin1 G - Gate
- Pin2 C & backside - Collector
- Pin3 E - Emitter

TO-247



Top View



ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT
Collector-Emitter Voltage	V <sub>CE</sub>	1200	V
Gate-Emitter Voltage	V <sub>GE</sub>	±30	
Continuous Collector Current (T <sub>J</sub> = 150 °C)	V <sub>GE</sub> at 15 V	T <sub>C</sub> = 25 °C	90
		T <sub>C</sub> = 100 °C	75
Pulsed Collector Current <sup>a</sup>	I <sub>CM</sub>	225	A
Diode Forward Current <sup>b</sup>	I <sub>F</sub>	90	A
Maximum Power Dissipation	P <sub>D</sub>	T <sub>C</sub> = 25 °C	880
		T <sub>C</sub> = 100 °C	440
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Short Circuit Withstand Time <sup>TC=150</sup>	tsc	V <sub>GE</sub> = 15V, V <sub>CE</sub> 400V	3
Short Circuit Withstand Time <sup>TC=100</sup>		V <sub>GE</sub> = 15V, V <sub>CE</sub> 330V	5
Soldering Recommendations (Peak Temperature) <sup>c</sup>		for 10 s	260
			°C

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- Current limited by maximum junction temperature.
- 1.6 mm from case.

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	40	°C/W
Maximum Junction-to-Case	$R_{thJC}$	-	0.17	

SPECIFICATIONS ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Collector-Emitter Breakdown Voltage	$BV_{CE}$	$V_{GE} = 0\text{ V}, I_C = 250\text{ }\mu\text{A}$ $V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$		1200 1200	- -	- -	V
Gate-Source Threshold Voltage (N)	$V_{GE(th)}$	$V_{CE} = V_{GE}, I_D = 250\text{ }\mu\text{A}$		4	5	6	V
Zero Gate Voltage Collector Current	$I_{CES}$	$V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}, T_J = 25\text{ }^\circ\text{C}$		-	1	20	$\mu\text{A}$
		$V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$		-	1000	-	$\mu\text{A}$
Gate-Emitter Leakage Current	$I_{GES}$	$V_{CE} = 0\text{ V}, V_{GS} = \pm 2.0\text{ V}$		-	-	100	nA
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{GE} = 15\text{ V}$	$I_C = 75\text{ A}$	-	1.8	2.1	V
Forward Transconductance	$g_{fs}$	$V_{CE} = 20\text{ V}, I_C = 75\text{ A}$		-	40	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{ies}$	$V_{GE} = 0\text{ V}, V_{CE} = 25\text{ V},$ $f = 500\text{ KHz}$		-	8000	-	pF
Output Capacitance	$C_{oes}$			-	230	-	
Reverse Transfer Capacitance	$C_{res}$			-	70	-	
Turn-on Energy	$E_{on}$	$V_{CE} = 400\text{ V}, V_{GE} = 0/15\text{V},$ $I_C = 75\text{ A}, R_g = 10\Omega$		-	0.68	-	nJ
Turn-off Energy	$E_{off}$			-	0.35	-	
Total Gate Charge	$Q_g$	$V_{GE} = 15\text{ V}$	$I_C = 75\text{ A}, V_{CE} = 400\text{ V}$	-	190	-	nC
Gate-Emitter Charge	$Q_{ge}$			-	18	-	
Gate to Collector Charge	$Q_{gc}$			-	45	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{CE} = 400\text{ V}, V_{GE} = 0/15\text{V},$ $I_C = 75\text{ A}, R_g = 10\Omega$		-	68	-	ns
Rise Time	$t_r$			-	58	-	
Turn-Off Delay Time	$t_{d(off)}$			-	196	-	
Fall Time	$t_f$			-	38	-	
Internal emitter inductance measured 5 mm	$L_E$			-	13	-	nH
<b>Diode Characteristics</b>							
Diode Forward Current	$I_F$	IGBT symbol showing the integral reverse junction diode		-	-	90	A
Pulsed Diode Forward Current	$I_{FM}$			-	-	225	
Diode Forward Voltage	$V_F$	$I_F = 30\text{ A}$		-	1.65	2.0	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25\text{ }^\circ\text{C}, I_F = 30\text{ A},$ $dI_F/dt = 200\text{ A}/\mu\text{s}, V_R = 400\text{ V}$		-	75	-	ns
Reverse Recovery Charge	$Q_{rr}$			-	0.5	-	$\mu\text{C}$
Reverse Recovery Current	$I_{RRM}$			-	13	-	A

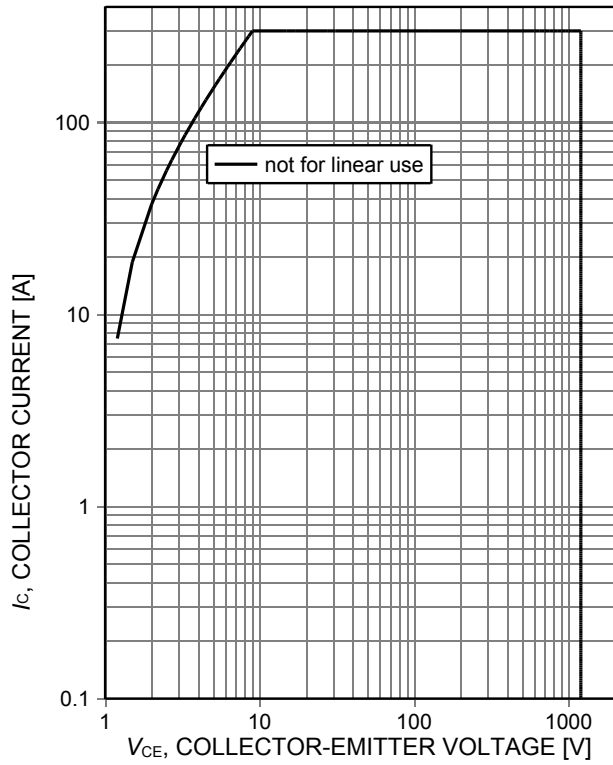


Figure 1. Forward bias safe operating area

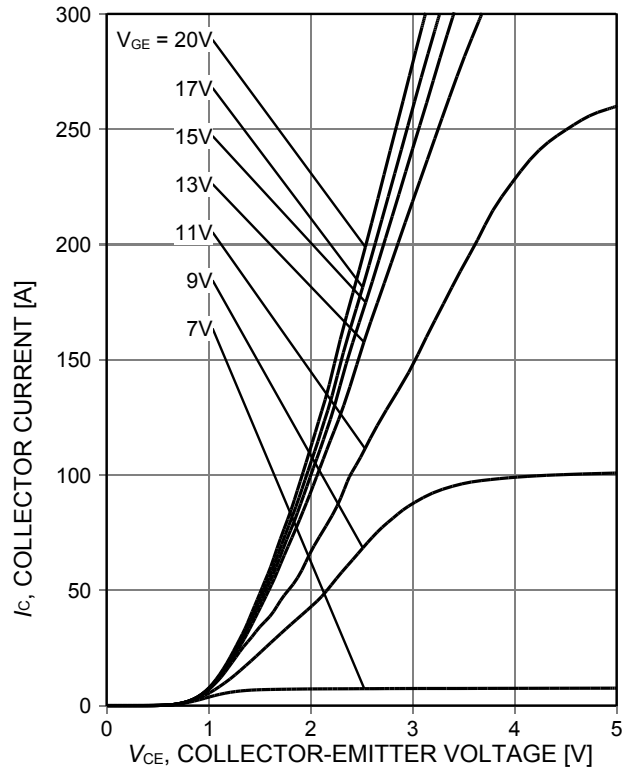


Figure 2. Typical output characteristic

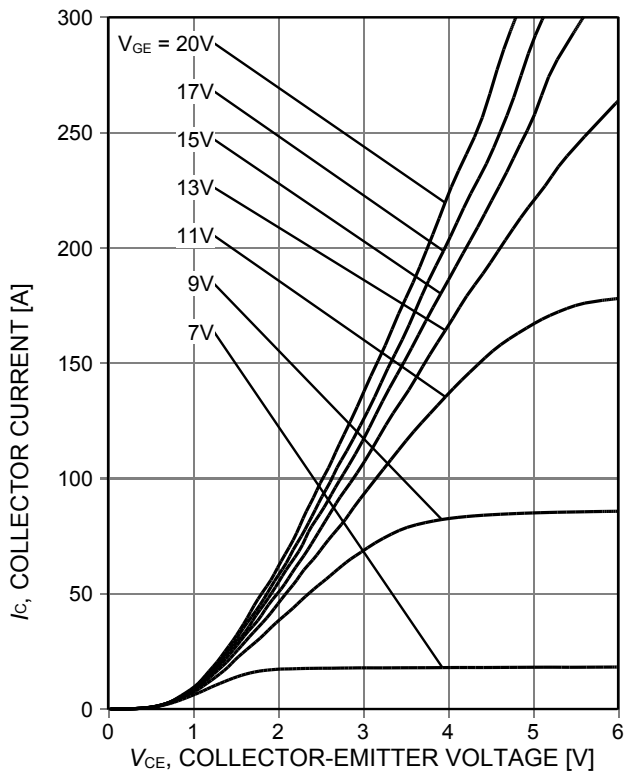


Figure 3. Typical output characteristic

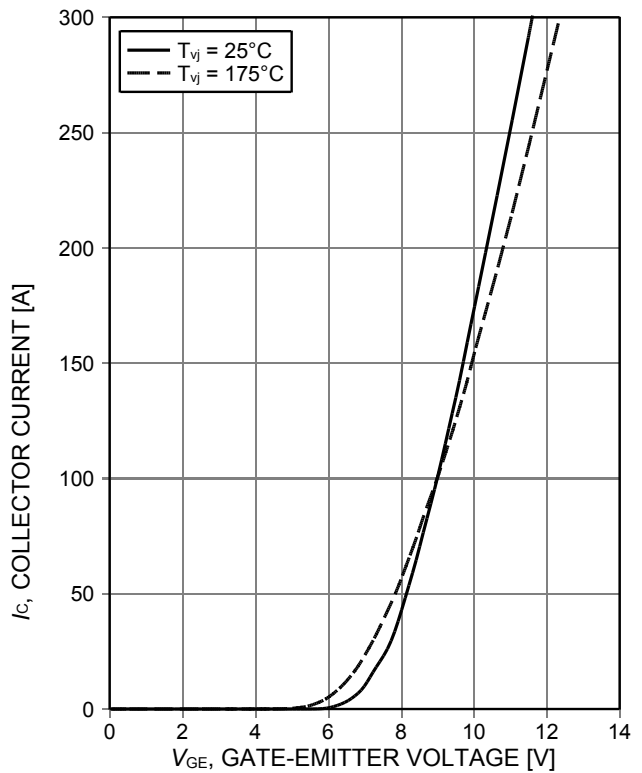


Figure 4. Typical transfer characteristic

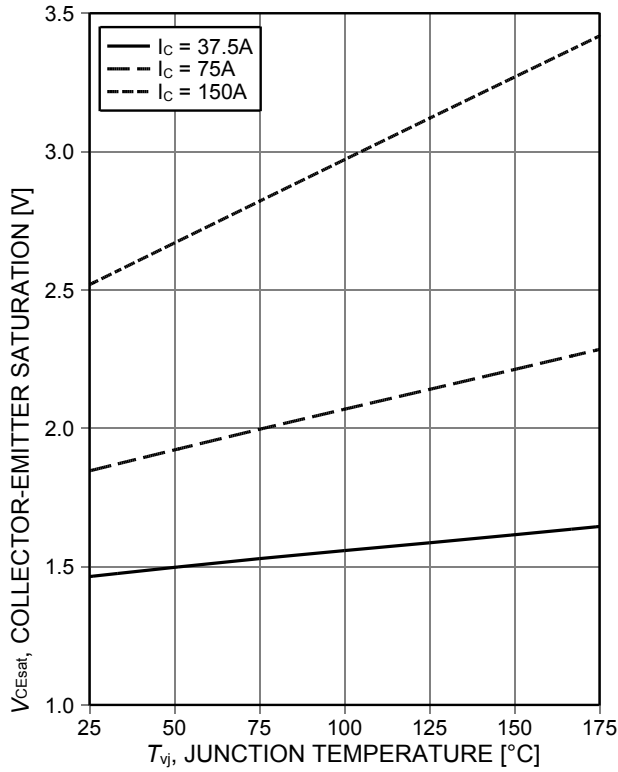


Figure 5. Typical collector-emitter saturation voltage as a function of junction temperature

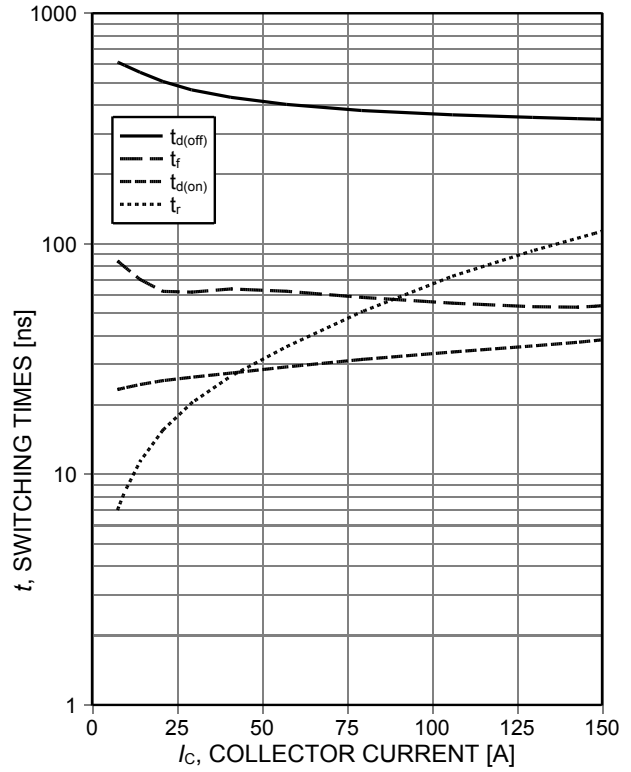


Figure 6. Typical switching times as a function of collector current

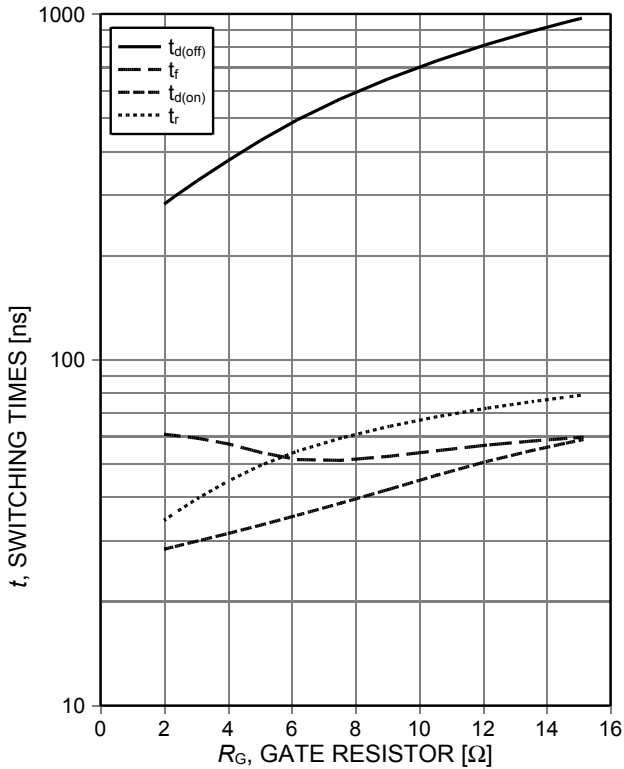


Figure 7. Typical switching times as a function of gate resistor

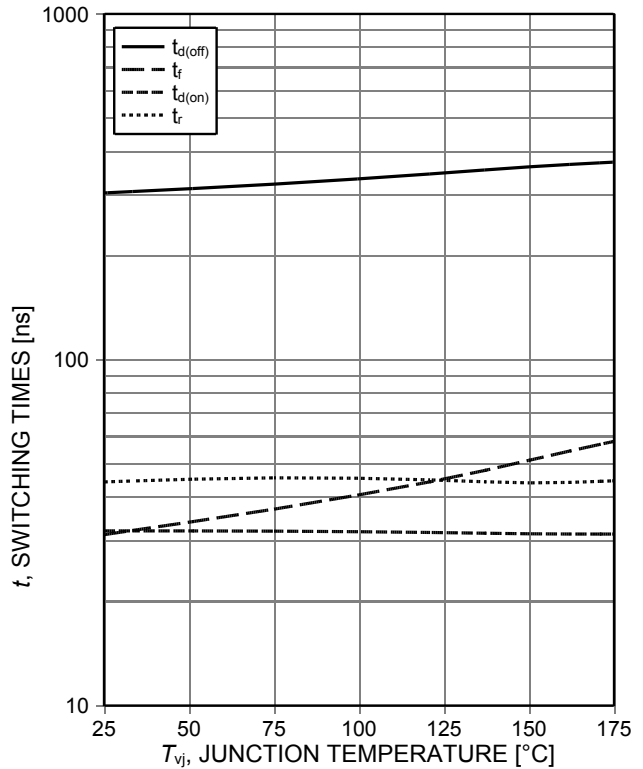


Figure 8. Typical switching times as a function of junction temperature

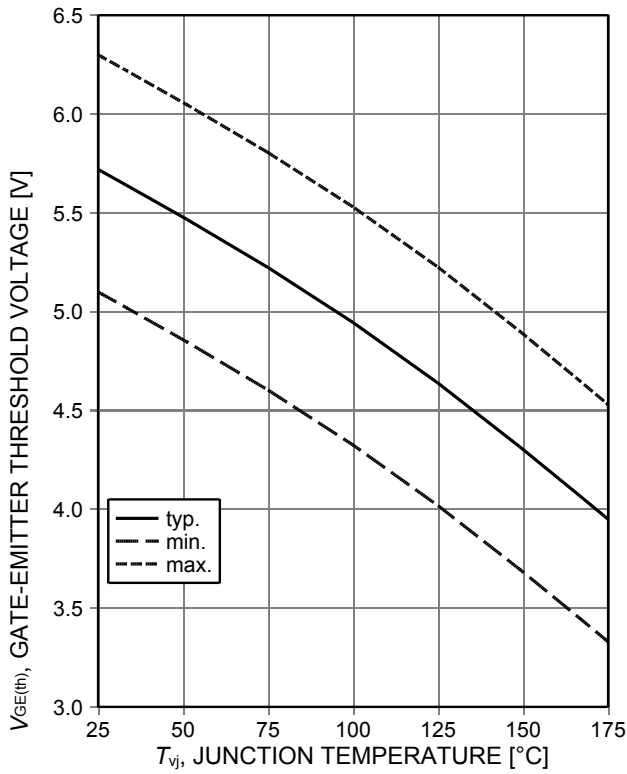


Figure 9. Gate-emitter threshold voltage as a function of junction temperature

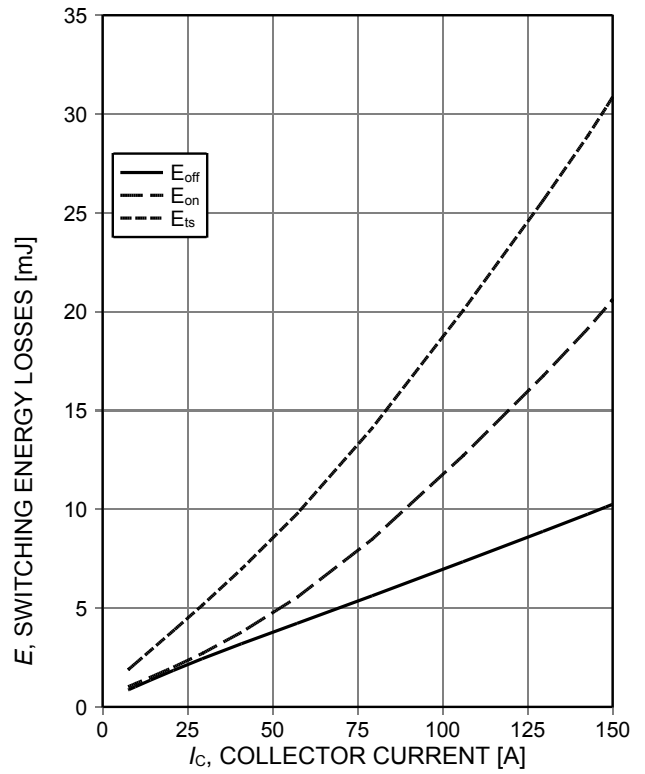


Figure 10. Typical switching energy losses as a function of collector current

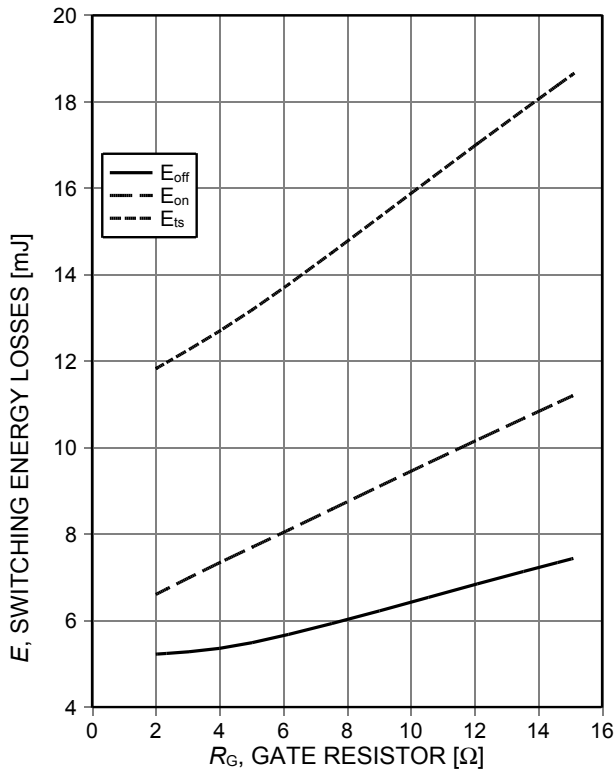


Figure 11. Typical switching energy losses as a function of gate resistor

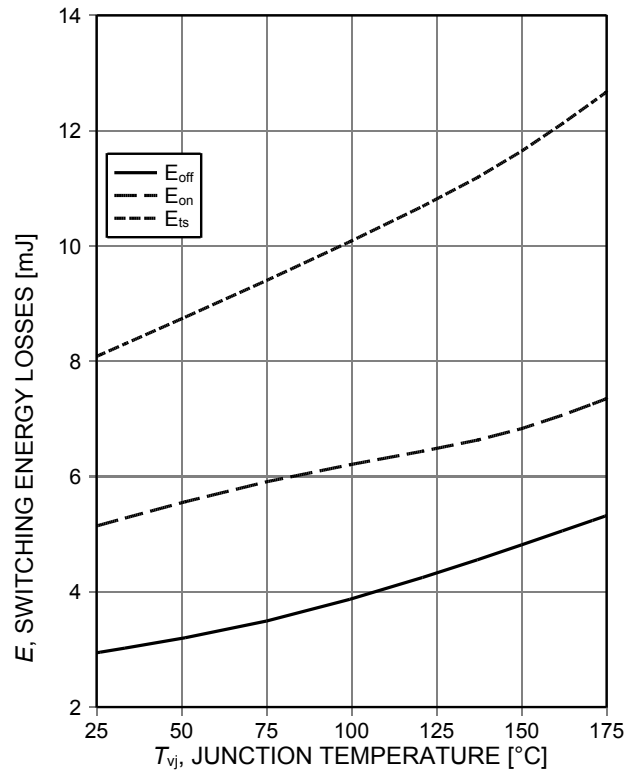


Figure 12. Typical switching energy losses as a function of junction temperature

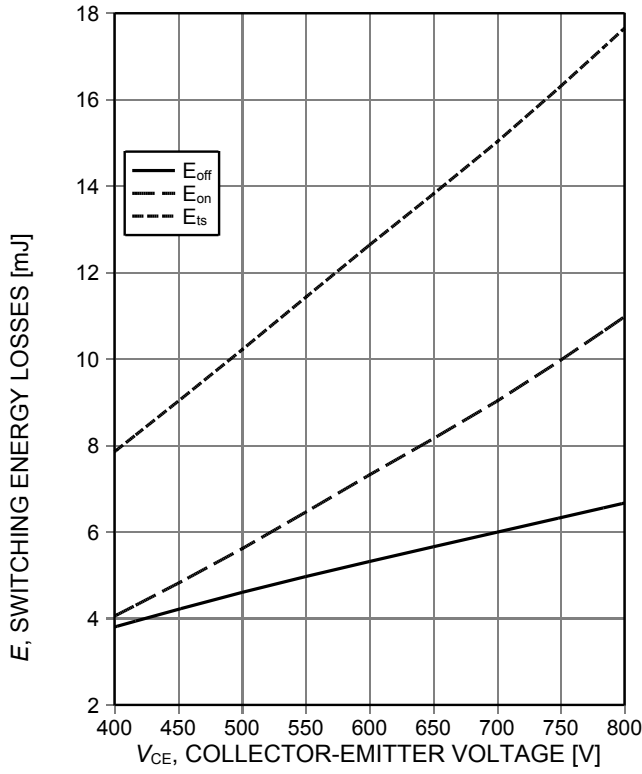


Figure 13. Typical switching energy losses as a function of collector emitter voltage

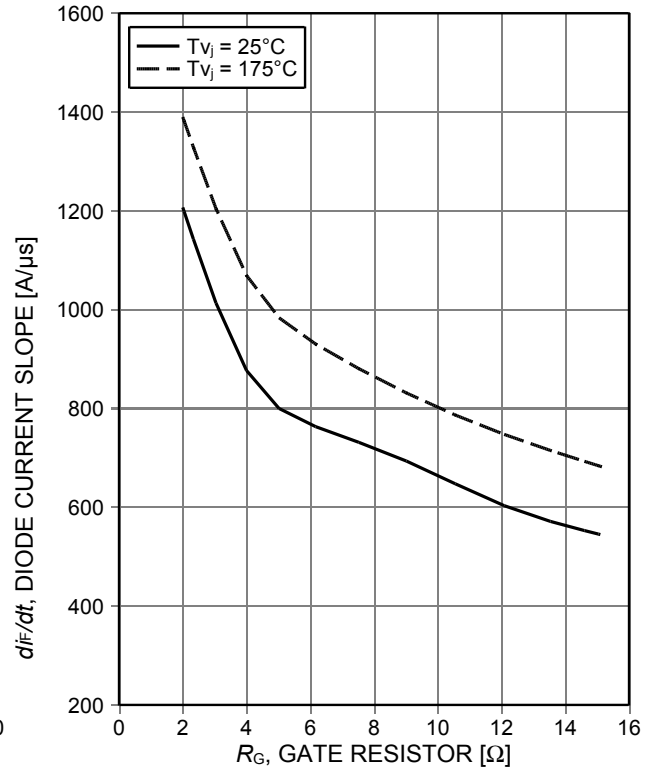


Figure 14. Typical diode current slope as a function of gate resistor

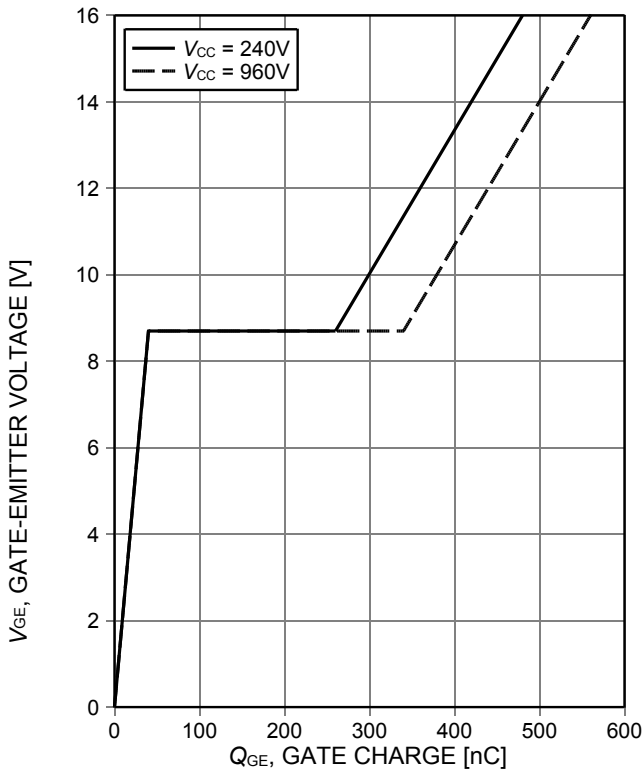


Figure 15. Typical gate charge

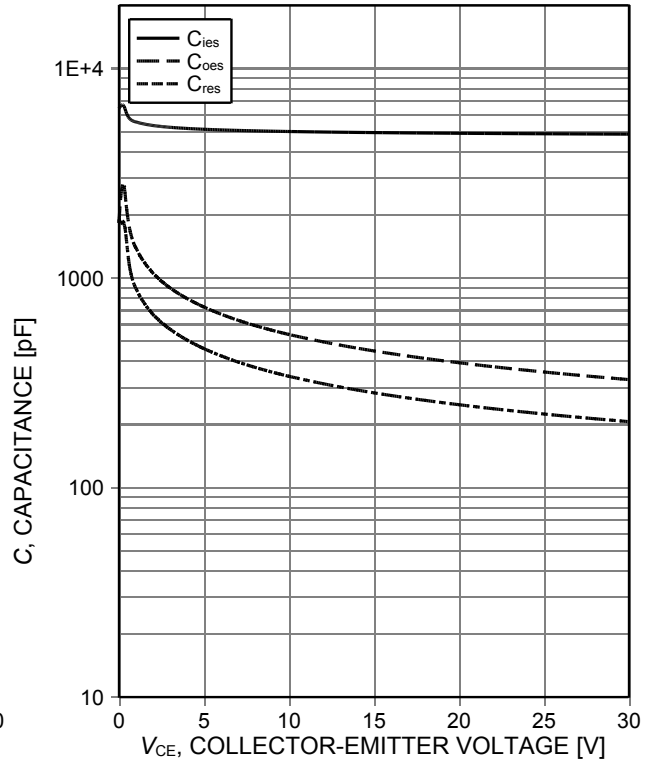


Figure 16. Typical capacitance as a function of collector-emitter voltage

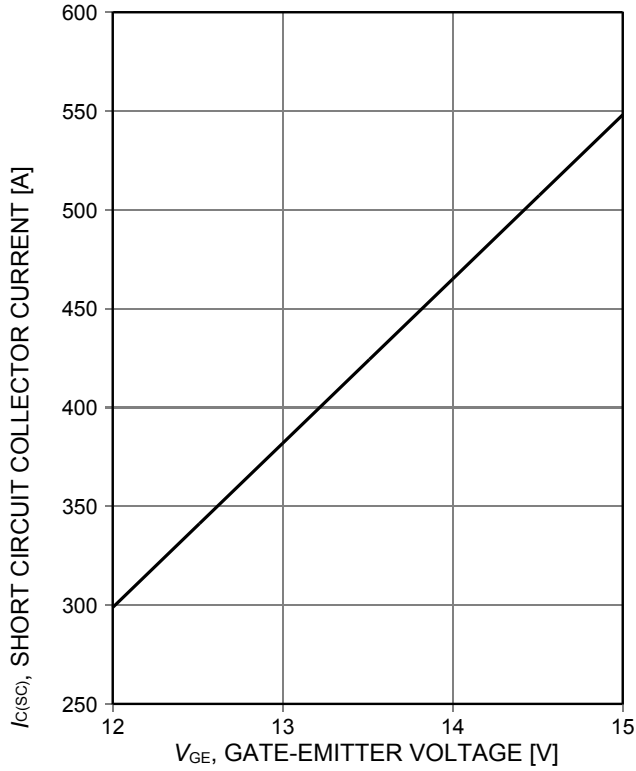


Figure 17. Typical short circuit collector current as a function of gate-emitter voltage

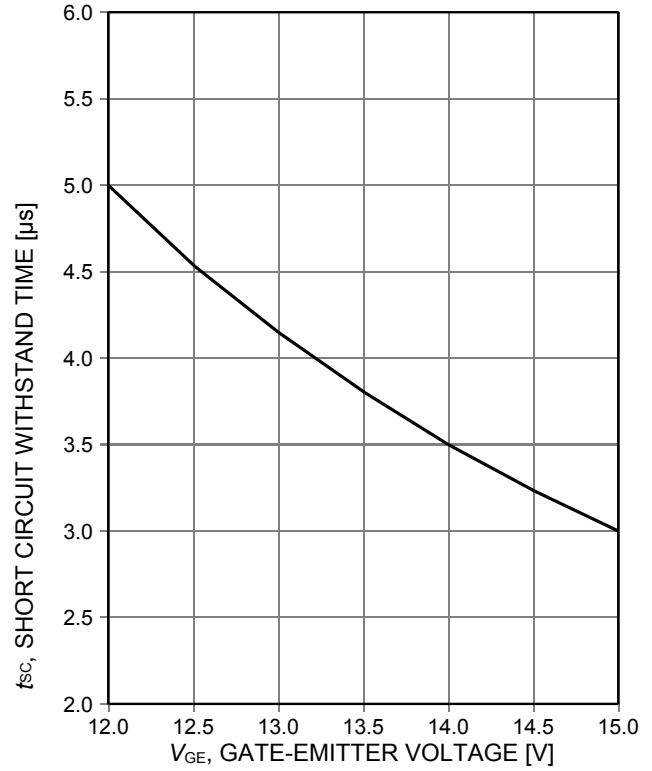


Figure 18. Short circuit withstand time as a function of gate-emitter voltage

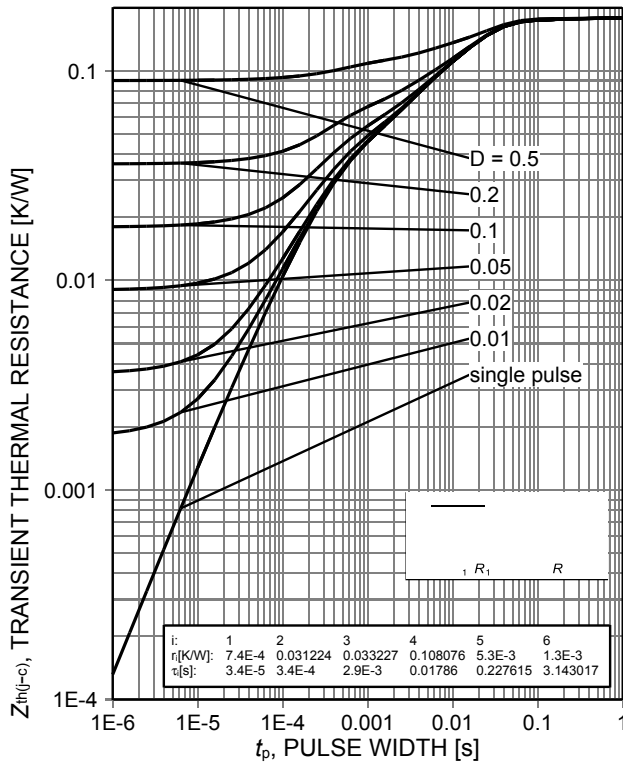


Figure 19. IGBT transient thermal resistance

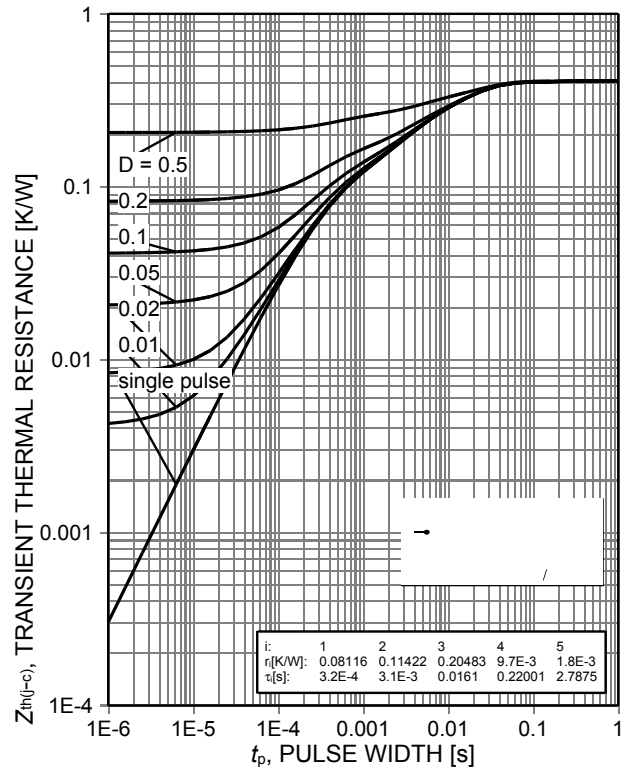


Figure 20. Diode transient thermal impedance as a function of pulse width

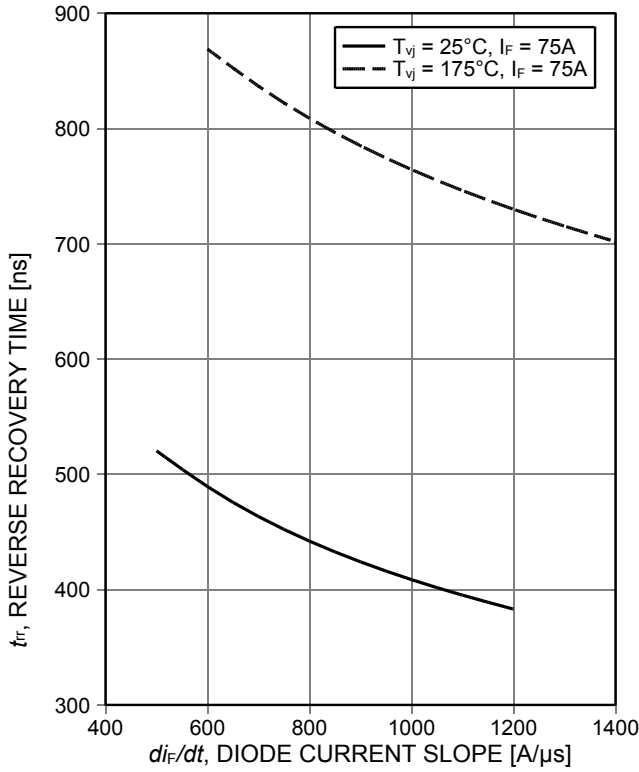


Figure 21. Typical reverse recovery time as a function of diode current slope

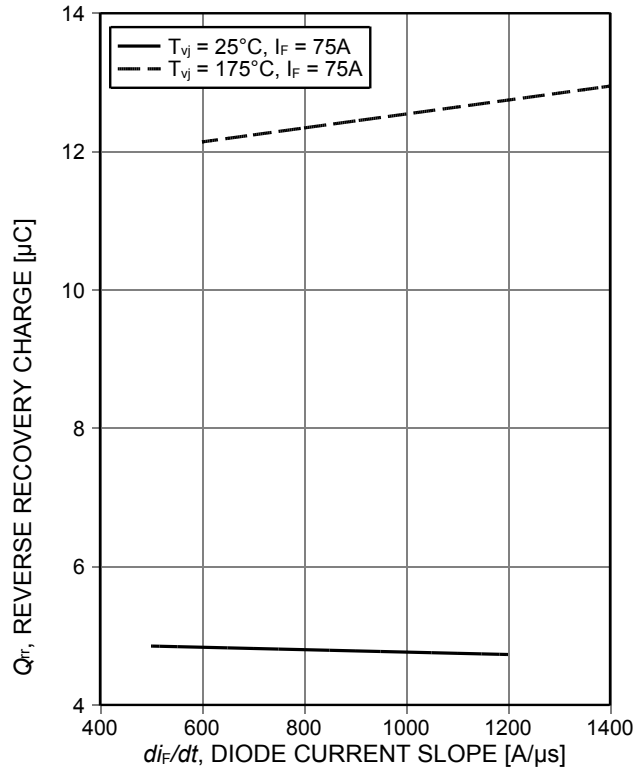


Figure 22. Typical reverse recovery charge as a function of diode current slope

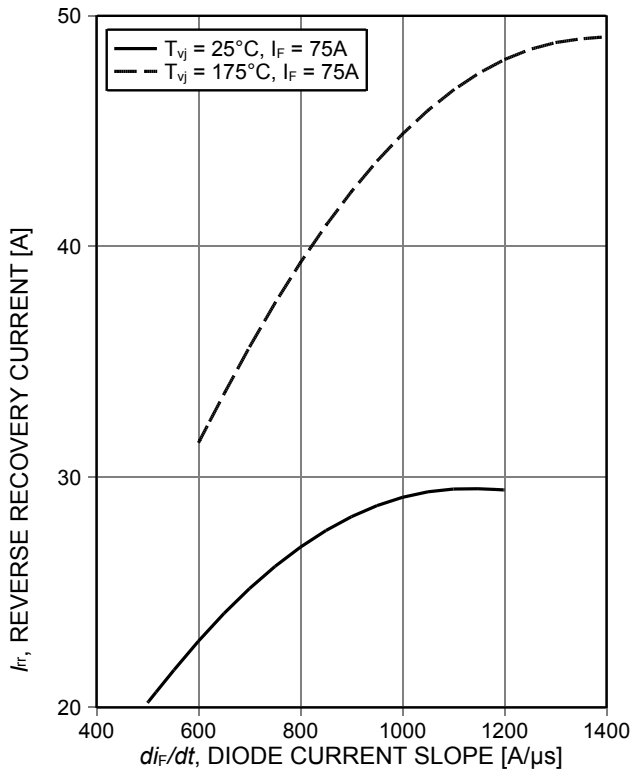


Figure 23. Typical reverse recovery current as a function of diode current slope

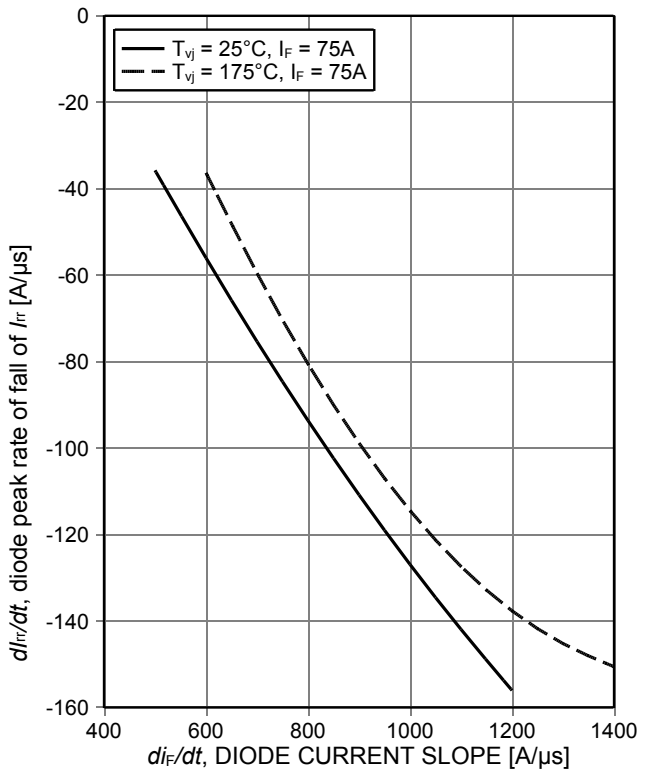


Figure 24. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope

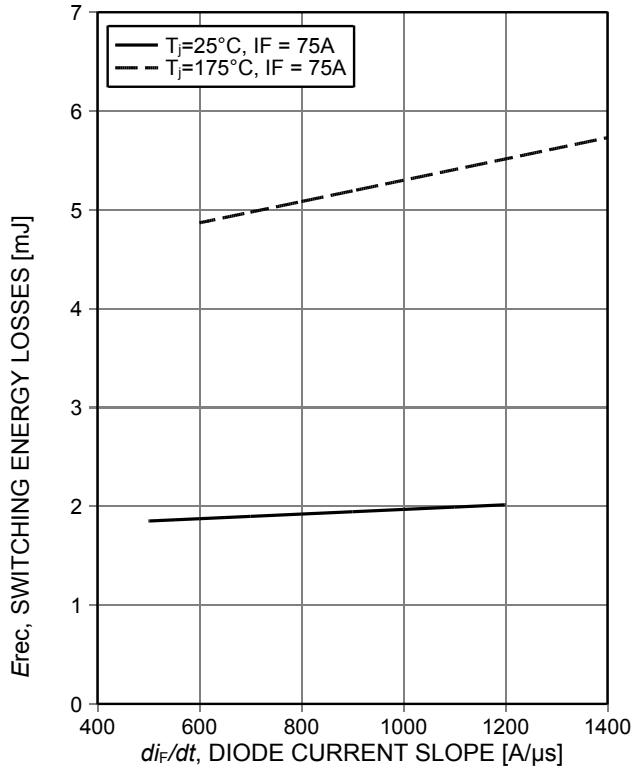


Figure 25. Typical reverse energy losses as a function of diode current slope

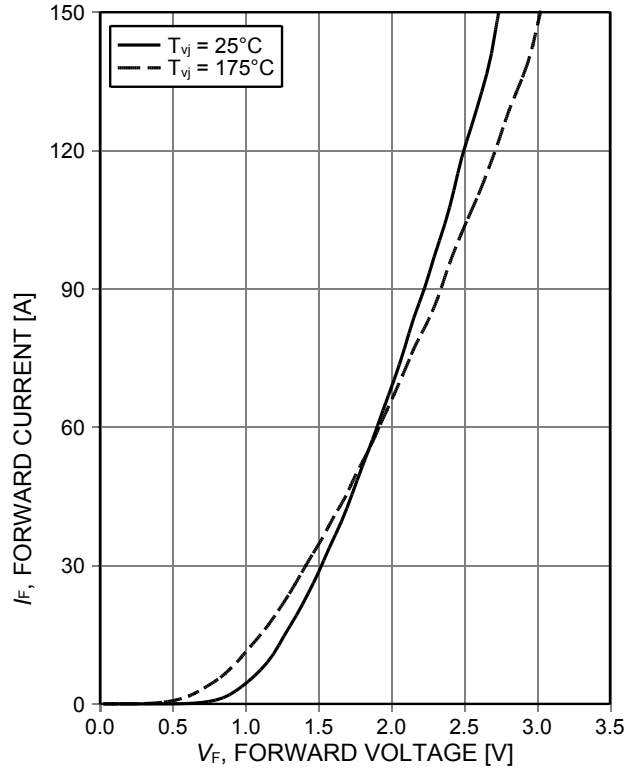


Figure 26. Typical diode forward current as a function of forward voltage

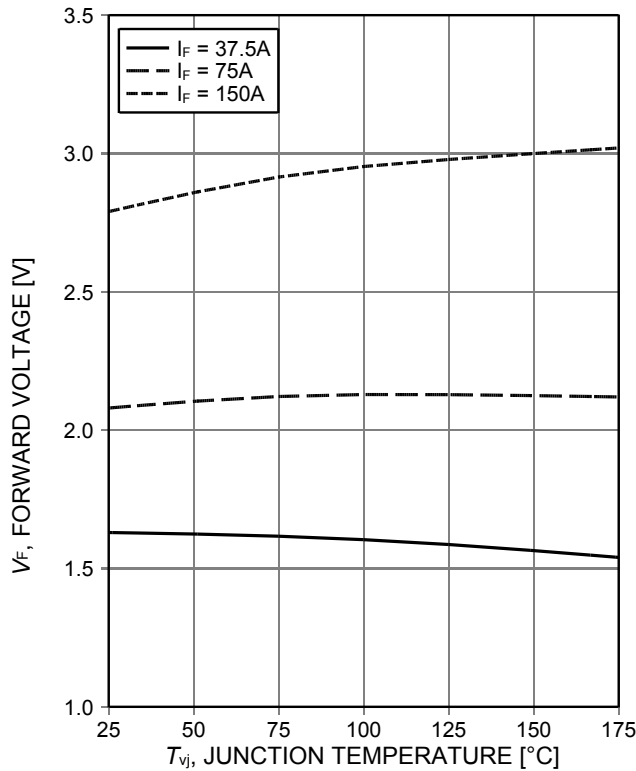


Figure 27. Typical diode forward voltage as a function of junction temperature



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